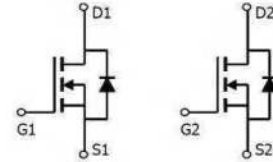


N-CHANNEL POWER MOSFET

Features

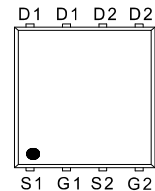
- 30V, 12A
 $R_{DS(ON)} < 25m\Omega @ V_{GS}=10V$ TYP: 17m Ω
 $R_{DS(ON)} < 26m\Omega @ V_{GS}=4.5V$ TYP: 19m Ω
- Advanced Trench Technology
- Lead free product is acquired
- ESD > 2KV



Schematic diagram

Applications

- Interfacing Switching
- Load Switch
- PWM applications
- Halogen-free



pin assignment

Package Marking and Ordering Information

Device Marking	Device	Device Package	Packaging Code	Reel Size	Quantity(PCS)
D12N30	RMD12N30ED3	DFN3 X3	-W	13inch	5000

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ($T_c=25^\circ\text{C}$)	I_D	12	A
Continuous Drain Current ($T_c=100^\circ\text{C}$)	I_D	7.5	A
Pulsed Drain Current ⁽¹⁾	I_{DM}	48	A
Drain Power Dissipation	P_D	19.2	W
Single Pulsed Avalanche Energy ⁽²⁾	E_{AS}	25	mJ
Thermal Resistance from Junction to Ambient ⁽³⁾	$R_{\theta JA}$	45	$^\circ\text{C}/\text{W}$
Thermal Resistance from Junction to Case	$R_{\theta JC}$	6.5	$^\circ\text{C}/\text{W}$
Junction Temperature	T_J	-55~ +150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~ +150	$^\circ\text{C}$

Notes:

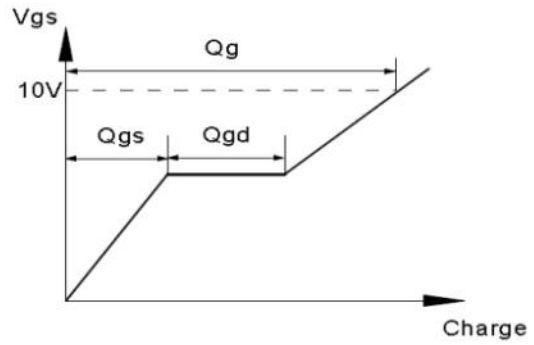
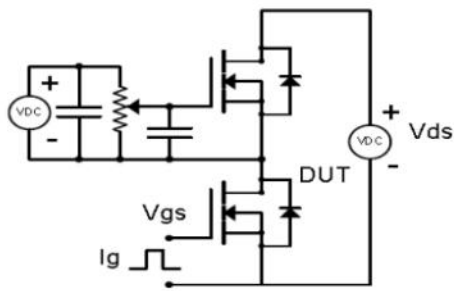
- 1) Repetitive Rating: pulse width limited by maximum junction temperature
- 2) EAS condition : $T_J=25^\circ\text{C}$, $V_{DD} 15V, V_G=10V, L=0.5mH, R_g=25\Omega, I_{AS} 10A$
- 3) The value of $R_{\theta JA}$ Mounted on FR4 Board (25.4mm*25.4mm*t1.6mm) With 2oz Copper $T_A=25^\circ\text{C}$

MOSFET ELECTRICAL CHARACTERISTICS(T_J=25°C unless otherwise noted)

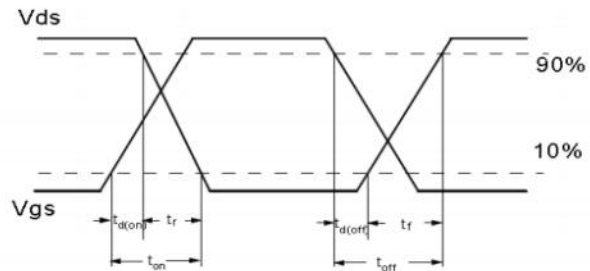
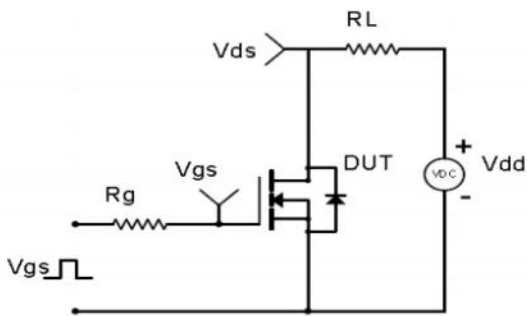
Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D =250μA	30	33	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =30V, V _{GS} = 0V	-	-	1	uA
Gate-body leakage current	I _{GSS}	V _{GS} = ± 12V, V _{DS} = 0V	-	-	±100	nA
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	0.4	1.0	1.5	V
Drain-source on-resistance	R _{DS(on)}	V _{GS} =10V, I _D =3A	-	17	25	mΩ
		V _{GS} =4.5V, I _D =2A	-	19	26	mΩ
Forward transconductance	R _g	V _{GS} = 0V, V _{DS} = 0V, f=1.0MHz	-	1.9	-	Ω
Dynamic characteristics						
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f=1MHz	-	700	-	pF
Output Capacitance	C _{oss}		-	66	-	
Reverse Transfer Capacitance	C _{rss}		-	52	-	
Switching characteristics						
Turn-on delay time	t _{d(on)}	V _{DD} =10V, I _D =3A, R _G 3.0Ω, V _{GS} 10V	-	12	-	nS
Turn-on rise time	t _r		-	52	-	
Turn-off delay time	t _{d(off)}		-	17	-	
Turn-off fall time	t _f		-	10	-	
Total Gate Charge	Q _g	V _{DS} =20V, I _D =2A, V _{GS} 10V	-	18	-	nC
Gate-Source Charge	Q _{gs}		-	1.46	-	
Gate-Drain Charge	Q _{gd}		-	2.06	-	
Source-Drain Diode characteristics						
Diode Forward voltage	V _{SD}	T _J =25°C, V _{GS} =0V, I _S =2A	-	0.8	1.1	V
Diode Forward current	I _S	T _C =25°C	-	-	12	A
Body Diode Reverse Recovery Time	T _{rr}	T _J =25°C, V _D =20V,	-	8.5	-	nS
Body Diode Reverse Recovery Charge	Q _{rr}	di/dt=100A/us, I _F =3A	-	2.2	-	nC

Test Circuit & Waveform

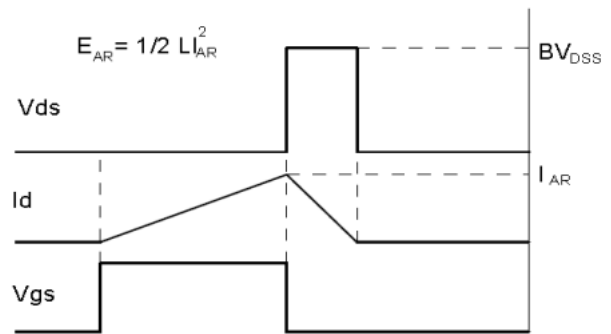
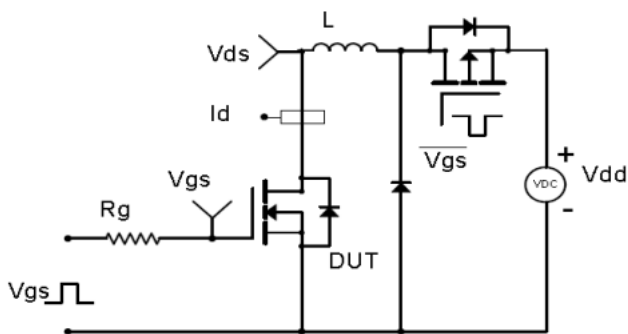
Gate Charge Test Circuit & Waveform



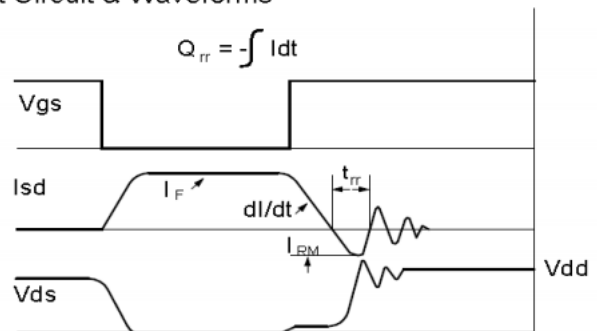
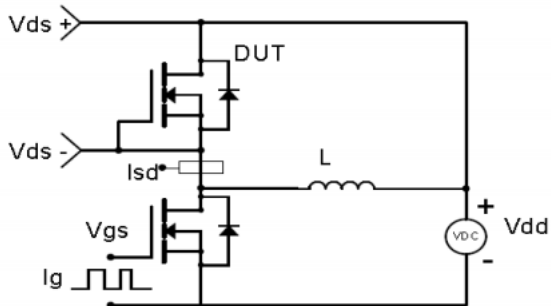
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



RATING AND CHARACTERISTICS CURVES (RMD12N30ED3)

Figure 1. Output Characteristics

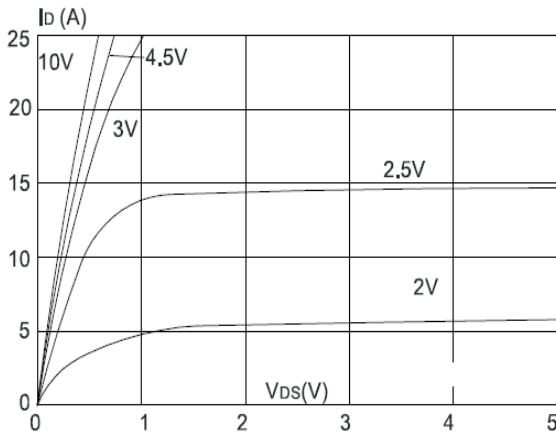


Figure 2. Transfer Characteristics

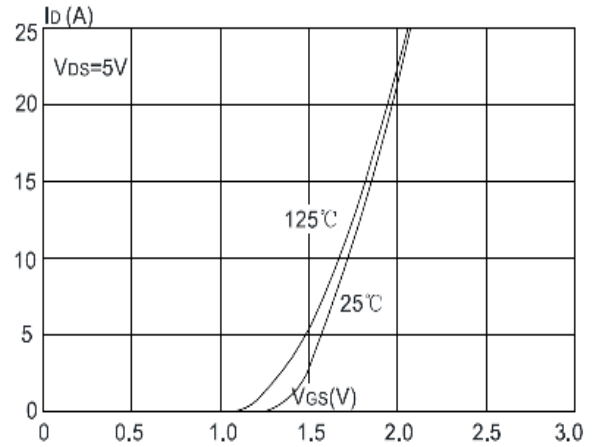


Figure 3. Source Drain Forward Characteristics

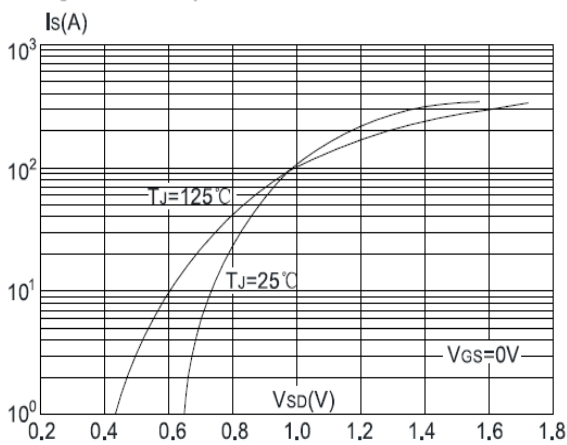


Figure 4. Gate-Charge Characteristics

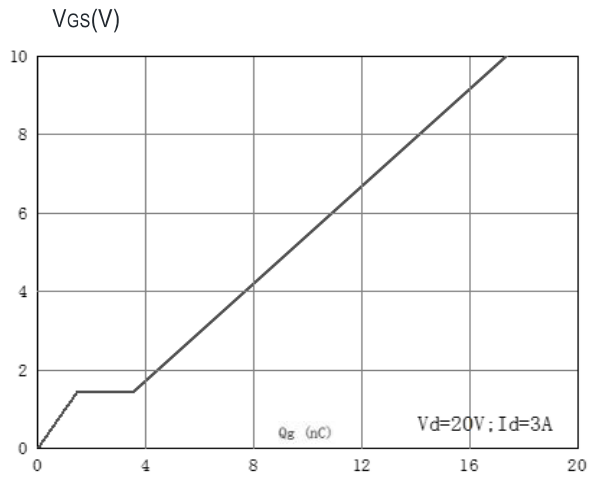


Figure 5. On-Resistance vs. Drain Current and Gate Voltage

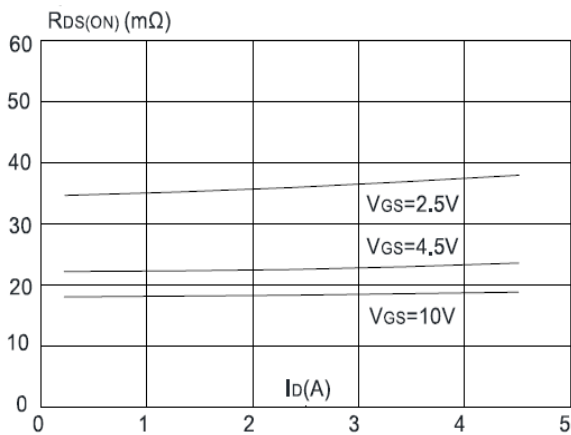
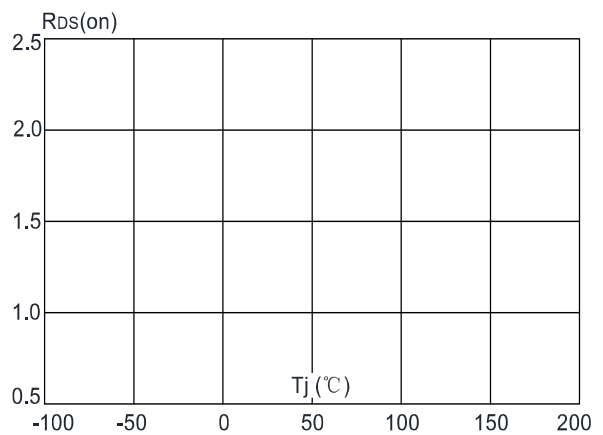


Figure 6. Normalized $R_{DS(on)}$ vs Junction Temperature



RATING AND CHARACTERISTICS CURVES (RMD12N30ED3)

Figure 7: V_{th} vs Junction Temperature

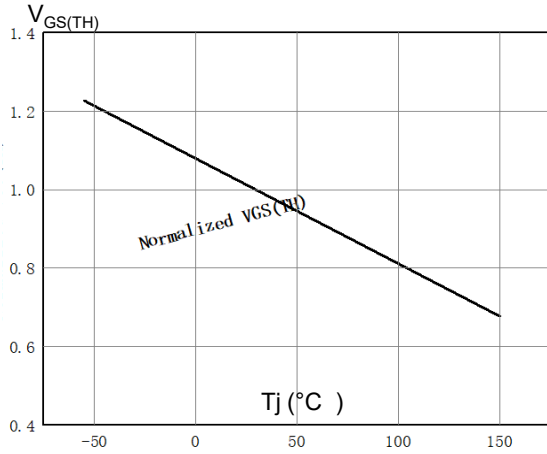


Figure 8: $V_{BR(DSS)}$ vs. Junction Temperature

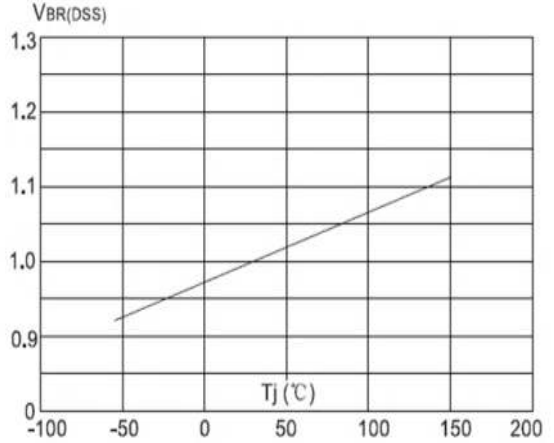


Figure 9. Capacitance

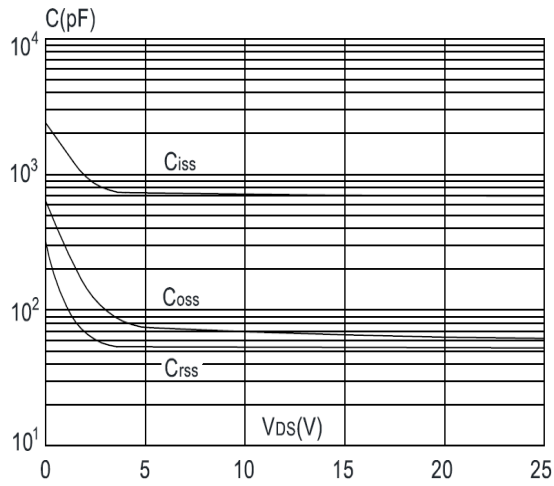


Figure 10. On-Resistance vs. Gate-Source Voltage

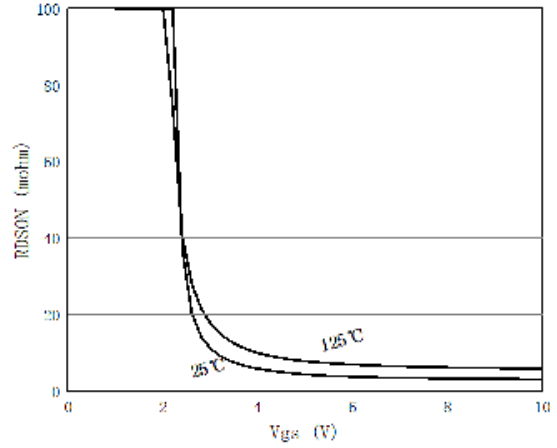


Figure 11. Current De-rating

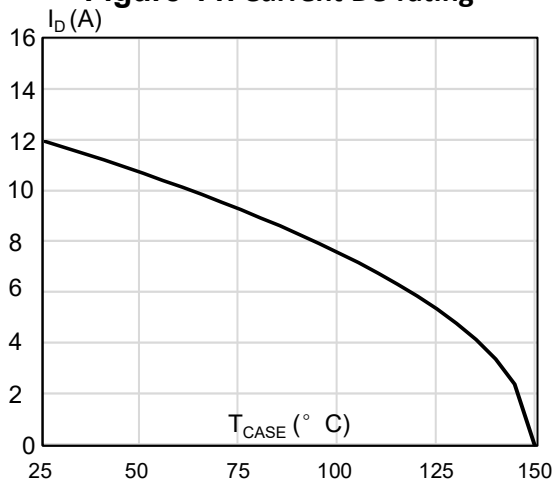
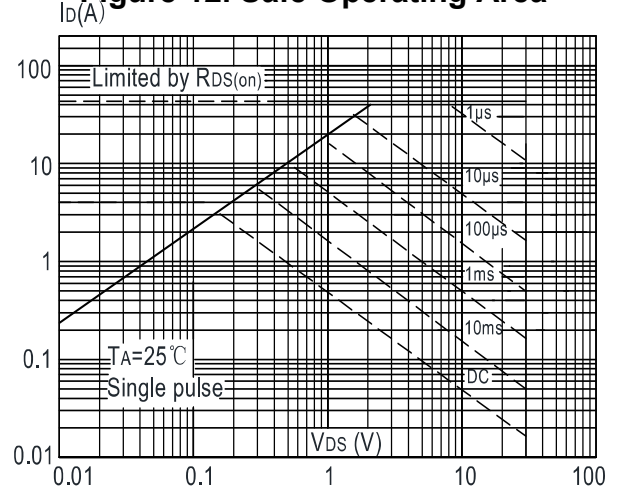
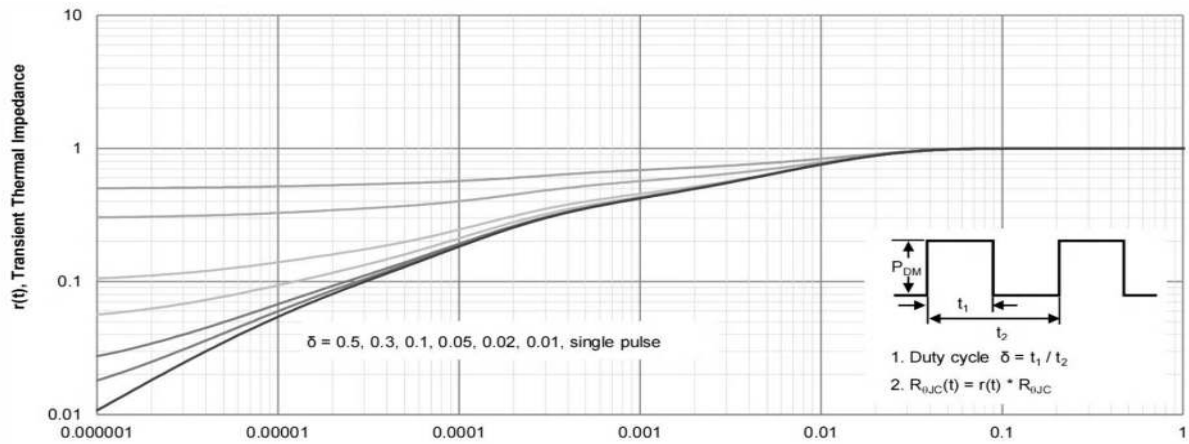


Figure 12. Safe Operating Area



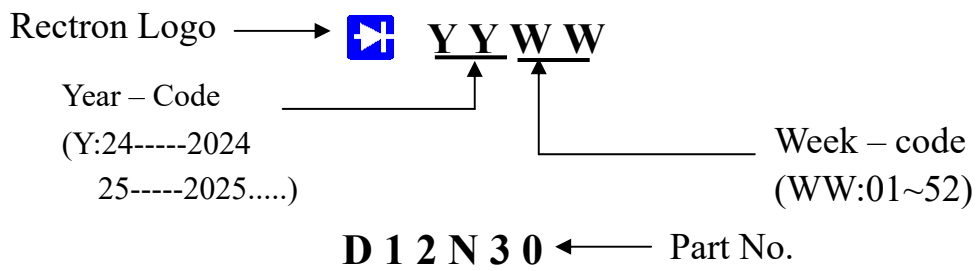
RATING AND CHARACTERISTICS CURVES (RMD12N30ED3)

Figure 13. Normalized Maximum Transient Thermal Impedance

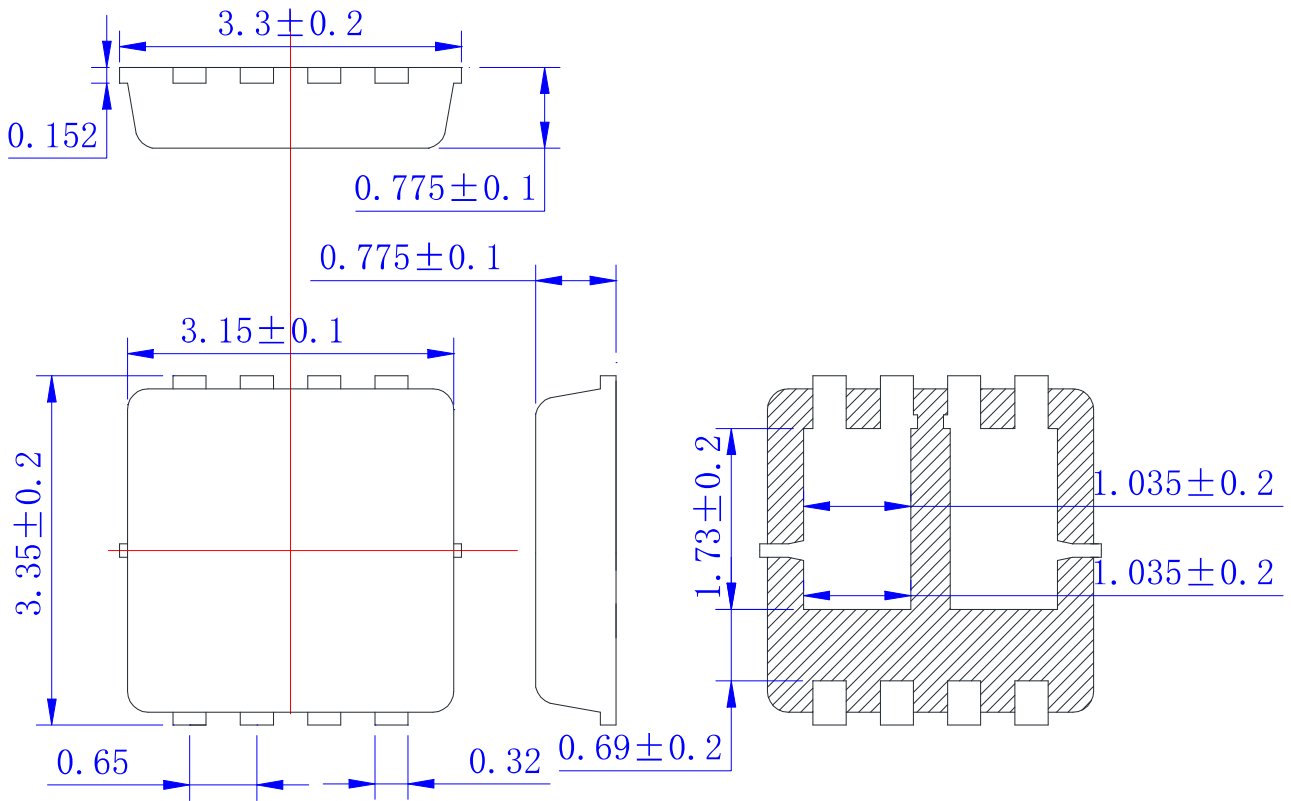


RECTRON

Marking on the body



PACKAGE OUTLINE DIMENSIONS



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